Receipt date: 01/07/2010

INFORMATION DISCLOSURE

STATEMENT BY APPLICANT

(Multiple sheets used when necessary)

SHEET 2 of 2

		PTO/SB/08 Modified
	Application No.	10/748,277
	Filing Date	December 31, 2003
	First Named Inventor	Tae-wan KIM, et al.
	Art Unit	1792
	Examiner	Luz L. ALEJANDRO MULERO
_	Attorney Docket No.	249/409

			FOREIGN PATE	ENT DOCUMENTS		
Examiner Initials	Cite No.	Foreign Patent Document Country Code-Number-Kind Code	Publication Date MM-DD-YYYY	Name of Patentee or Applicant	Pages, Columns, Lines Where Relevant Passages or Relevant Figures Appear	T <sup>1</sup>
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		* with English Abstract				

		NON PATENT LITERATURE DOCUMENTS	
Examiner Initials	Cite No.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T <sup>1</sup>
COORDINATION OF THE PROPERTY O	003000000	number(s), publisher, city and/or country where published.	· · · · · · · · · · · · · · · · · · ·
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Examiner Signature	/Luz Alejandro Mulero/	Date Considered	01/14/2010

**Examiner:** Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Receipt date: 01/07/2010

			PTO/SB/08 Modifie
	Application No.	10/748,277	OF
INFORMATION DISCLOSURE	Filing Date	December 31, 2003	6, -
STATEMENT BY APPLICANT	First Named Inventor	Tae-wan KIM, et al.	2 200
STATEMENT BY APPLICANT	Art Unit	1792	JAN O 1 20
(Multiple sheets used when necessary)	Examiner	Luz L. ALEJANDRO MU	
SHEET 1 of 2	Attorney Docket No.	249/409	TE TRAUE

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Examiner Signature	/Luz Alejandro Mulero/	Date Considered 01/14/2	2010

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T<sup>1</sup> - Place a check mark in this area when an English language Translation is attached.